Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/628,466	YEN, CHI-YU
Examiner	Art Unit

2832

Michael A. Friedhofer

	SEAR	CHED	
Class	Subclass	Date	Examiner
200	5r,5a,512- 514,517, 341,344	3/3/2005	MAF
200	345	3/3/2005	MAF
341	22	3/3/2005	MAF
345	168,169	3/3/2005	MAF
400	490-496	3/3/2005	MAF
		,	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
200	5r,5a	3/3/2005	MAF	
200	512-514	3/3/2005	MAF	
200	517,341	3/3/2005	MAF	
200/34	44,345	3/3/2005	MAF	

(INCLUDING SEARC	H STRATEGY	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR				
	-					
•						
		1				
		-				